| | Application/Control No. | Applicant(s)/Patent Under Reexamination |
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| Issue Classification | 09863706 | GETTEMY ET AL. |
| | Examiner | Art Unit |
| | Nguyen, Jennifer T | 2629 |

| | | ORIGINAL | | | | | | | INTERNATIONAL | INTERNATIONAL CLASSIFICATION | |
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| Jennifer T. Nauven | ven | 2/27/07 | | | | 700 | | | | Total Claims Allowed: | ıs Allowed: |
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